

<b>Notice of References Cited</b>	Application/Control No. 10/573,770		Applicant(s)/Patent Under Reexamination LAIHO ET AL.	
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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,083,221 A	04-1978	Whitted, Robert Lee	72/405.06
*	B	US-5,574,964 A	11-1996	Hamlin, Christopher L.	725/78
*	C	US-5,623,531 A	04-1997	Nilssen, Ole K.	379/56.2
*	D	US-5,644,622 A	07-1997	Russell et al.	455/422.1
*	E	US-5,822,705 A	10-1998	Lehtola, Antero	455/575.7
*	F	US-5,861,851 A	01-1999	Chang, Daniel	343/702
*	G	US-5,867,794 A	02-1999	Hayes et al.	455/557
*	H	US-6,031,492 A	02-2000	Griffin et al.	343/702
*	I	US-6,052,603 A	04-2000	Kinzalow et al.	455/557
*	J	US-6,073,003 A	06-2000	Nilssen, Ole K.	455/402
*	K	US-6,091,931 A	07-2000	Ben-Efraim et al.	455/3.02
*	L	US-6,167,278 A	12-2000	Nilssen, Ole K.	455/462
*	M	US-6,239,769 B1	05-2001	Ericsson et al.	343/906

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

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	U	
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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,295,033 B1	09-2001	Chatzipetros et al.	343/713
*	B	US-6,317,089 B1	11-2001	Wilson et al.	343/713
*	C	US-2002/0003495 A1	01-2002	JOHNSTONE et al.	342/357.13
*	D	US-2002/0021371 A1	02-2002	Konishi et al.	348/678
*	E	US-2002/0068549 A1	06-2002	TENDLER, ROBERT	455/414
*	F	US-2002/0081987 A1	06-2002	Yoshida et al.	455/277.1
*	G	US-6,434,187 B1	08-2002	Beard et al.	375/219
*	H	US-6,459,915 B2	10-2002	Nakamura et al.	455/571
*	I	US-2003/0014766 A1	01-2003	Dinwiddie et al.	725/126
*	J	US-6,519,328 B1	02-2003	Rumbaugh, Stephen Roy	379/93.06
*	K	US-6,549,774 B1	04-2003	Titlebaum et al.	455/427
*	L	US-2003/0192061 A1	10-2003	Hwangbo et al.	725/138
*	M	US-2003/0231864 A1	12-2003	Wakahara, Tatsuya	386/68

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
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	S					
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	X	

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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,696,922 B1	02-2004	Wong et al.	340/7.32
*	B	US-2004/0090352 A1	05-2004	Jaffe et al.	341/050
*	C	US-2004/0137929 A1	07-2004	Jones et al.	455/517
*	D	US-2004/0171377 A1	09-2004	Engstrom, G Eric	455/419
*	E	US-2004/0204192 A1	10-2004	Holloway et al.	455/575.1
*	F	US-2004/0260669 A1	12-2004	Fernandez, Dennis S.	707/001
*	G	US-6,885,674 B2	04-2005	Hunt et al.	370/420
*	H	US-6,892,080 B2	05-2005	Friesen et al.	455/571
*	I	US-6,952,576 B2	10-2005	Fish et al.	455/414.1
*	J	US-2005/0253973 A1	11-2005	Adachi et al.	348/838
*	K	US-7,081,857 B2	07-2006	Kinnunen et al.	343/702
*	L	US-7,107,063 B1	09-2006	Bates et al.	455/456.1
*	M	US-7,130,623 B2	10-2006	Kirkeby et al.	455/420

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,133,082 B2	11-2006	Limberg, Allen Le Roy	348/725
*	B	US-7,356,354 B2	04-2008	Itsukaichi, Atsushi	455/557
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
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	N					
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